Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/692,470	SAKAMOTO ET AL.	
Examiner	Art Unit	
Ana M. Fortuna	1723	

SEARCHED			
Class	Subclass	Date	Examiner
210	500.27	1/11/2006	AF
	500.36	1	.,
	500.23		
264	53		
	204		
	288.8		
	289.3		
	290.2		
428	315.5		
521	64		
	143	\sim	\downarrow
95	45,50		
95	4		1

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
210	50036	5/11/06	AF
	500.27		1
428	315.5	$\sqrt{}$	12

SEAR (INCLUDING SE	CH NOTES EARCH STRATEG	iY)
	DATE	EXMR
East serach	12/23/2009	5 AF
Inventors search	12/23/2009	5 AF
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